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Fairchild Semiconductor FDS5670

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August 1999

FDS5670

60V N-Channel PowerTrench™ MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

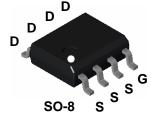
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications.

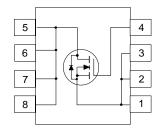
The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

• 10 A, 60 V.
$$R_{DS(ON)} = 0.014 \Omega @ V_{GS} = 10 V$$
 $R_{DS(ON)} = 0.017 \Omega @ V_{GS} = 6 V.$

- · Low gate charge.
- · Fast switching speed.
- High performance trench technology for extremely low $R_{\scriptscriptstyle DS(ON)}.$
- · High power and current handling capability.





Absolute Maximum Ratings $T_A = 25$ °C unless otherwise noted

3 *				
Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current - Continuous	(Note 1a)	10	А
	- Pulsed		50	
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T _J , T _{stg}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R _e JA	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R _e JC	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
FDS5670	FDS5670	13"	12mm	2500 units



Electrical Characteristics $T_{\Delta} = 25$ °C unless otherwise noted Units **Symbol Parameter** Min Max **Test Conditions** Typ **Off Characteristics** Drain-Source Breakdown Voltage ٧ $V_{GS}=0~V,~I_D=250~\mu A$ 60 Breakdown Voltage Temperature $I_D = 250 \,\mu\text{A}$, Referenced to 25°C 58 mV/°C ΔBV_{DSS} Coefficient ΔT_J Zero Gate Voltage Drain Current $V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}$ I_{DSS} μΑ Gate-Body Leakage Current, Forward $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ 100 nΑ IGSSF I_{GSSR} Gate-Body Leakage Current, Reverse $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ -100 nΑ On Characteristics (Note 2) Gate Threshold Voltage 2 2.4 4 ٧ $V_{GS(th)}$ $V_{DS}=V_{GS},\ I_D=250\ \mu A$ $\underline{\Delta V_{\text{GS(th)}}}$ Gate Threshold Voltage I_D = 250 μ A, Referenced to 25°C 6.8 mV/°C Temperature Coefficient ΔT_J R_{DS(on)} Static Drain-Source $V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ 0.012 0.014 Ω On-Resistance 0.019 V_{GS} = 10 V, I_D = 10 A, T_J =125°C 0.027 $V_{GS} = 6 \text{ V}, I_{D} = 9 \text{ A}$ 0.014 0.017 On-State Drain Current $V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$ 25 $I_{D(on)}$ Α Forward Transconductance $V_{DS} = 5 \text{ V}, I_{D} = 10 \text{ A}$ 39 S g_{FS} **Dynamic Characteristics** $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}$ 2900 pF Input Capacitance f = 1.0 MHz Coss Output Capacitance 685 pF C_{rss} Reverse Transfer Capacitance 180 рF Switching Characteristics (Note 2)

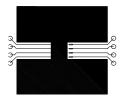
t _{d(on)}	Turn-On Delay Time	V _{DD} = 30 V, I _D = 1 A	16	29	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	10	20	ns
t _{d(off)}	Turn-Off Delay Time		50	80	ns
t _f	Turn-Off Fall Time		23	42	ns
Qg	Total Gate Charge	$V_{DS} = 20 \text{ V}, I_{D} = 10 \text{ A}$	49	70	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V,	9		nC
Q _{gd}	Gate-Drain Charge		10.4		nC

Drain-Source Diode Characteristics and Maximum Ratings

Is	Maximum Continuous Drain-Source Diode Forward Current			2.1	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A} \text{ (Note 2)}$	0.72	1.2	V

Notes:

R_{BJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BJA} is determined by the user's board design.



a) 50° C/W when mounted on a 0.5 in² pad of 2 oz. copper.



b) 105° C/W when mounted on a 0.02 in² pad of 2 oz. copper.



c) 125° C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2.0%





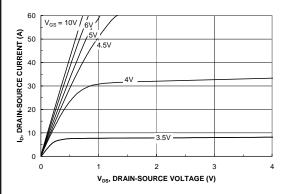


Figure 1. On-Region Characteristics.

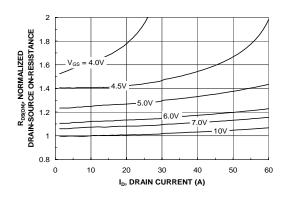


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

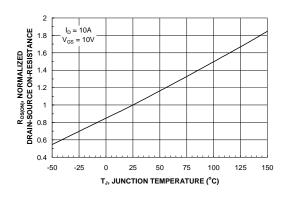


Figure 3. On-Resistance Variation with Temperature.

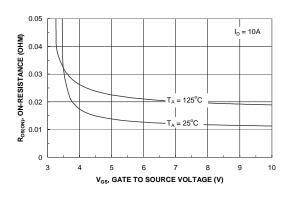


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

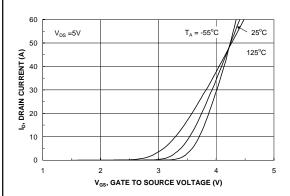


Figure 5. Transfer Characteristics.

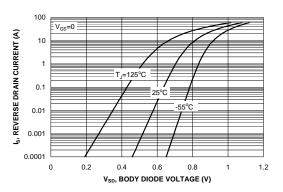
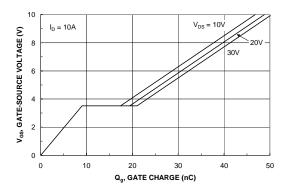


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.







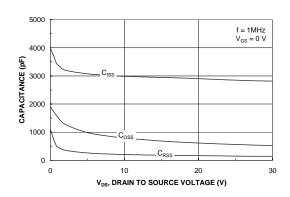
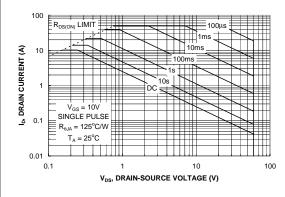


Figure 7. Gate-Charge Characteristics.





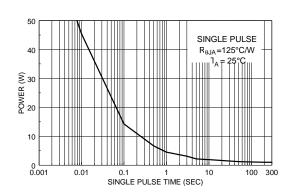


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

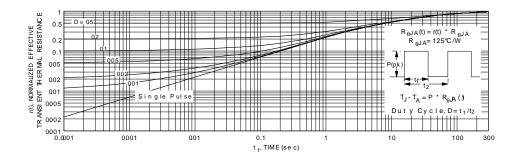


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient themal response will change depending on the circuit board design.



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